

**Search Notes****Application/Control No.**

10/743,459

**Applicant(s)/Patent under  
Reexamination**

HWANG ET AL.

**Examiner**

Leith A. Al-Nazer

**Art Unit**

2821

**SEARCHED**

| Class | Subclass           | Date      | Examiner |
|-------|--------------------|-----------|----------|
| 343   | 767, 770,<br>700MS | 7/15/2005 | LA       |
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**INTERFERENCE SEARCHED**

| Class | Subclass | Date      | Examiner |
|-------|----------|-----------|----------|
| 343   | 767, 770 | 7/15/2005 | LA       |
| 343   | 700MS    | 7/15/2005 | LA       |
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**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

|   | DATE      | EXMR |
|---|-----------|------|
| Updated EAST text search (see<br>"Examiner Search Notes") | 7/15/2005 | LA   |
| Consulted with primary examiner Tan<br>Ho                 | 7/15/2005 | LA   |
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